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Patent  
Attorney's Docket No. 027260-485

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of )  
Takehiko SHIMOMURA, et al. ) Group Art Unit: 2133  
Application No.: 09/939,602 ) Examiner: Unassigned  
Filed: August 28, 2001 )  
For: SCAN TEST SYSTEM FOR )  
SEMICONDUCTOR DEVICE )

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INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents  
Washington, D.C. 20231

Sir:

In accordance with the duty of disclosure as set forth in 37 C.F.R. § 1.56, Applicants hereby submit the following information in conformance with 37 C.F.R. §§ 1.97 and 1.98.

Pursuant to 37 C.F.R. § 1.98, a copy of each of the documents cited is enclosed.

Japanese Patent No. 5-322989, issued December 7, 1993 (English Abstract Attached);  
Japanese Patent No. 07-104039, issued April 21, 1995 (English Abstract Attached); and  
Japanese Patent No. 11-038091, issued February 12, 1999 (English Abstract Attached).

The documents are being submitted within 3 months of the filing or entry of the national stage of this application or before the first Office Action on the merits, whichever is later, therefore no fee or certification is required under 37 C.F.R. § 1.97(b).

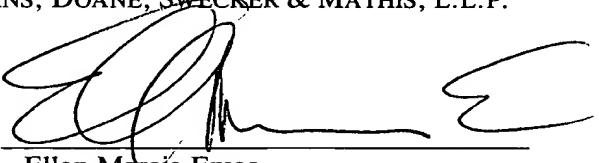
Information Disclosure Statement  
Application No. 09/939,602  
Attorney's Docket No. 027260-485  
Page 2

To assist the Examiner, the documents are listed on the attached form PTO-1449. It is respectfully requested that an Examiner initialed copy of this form be returned to the undersigned.

Respectfully submitted,

BURNS, DOANE, SWECKER & MATHIS, L.L.P.

By:

  
Ellen Marie Emas  
Registration No. 32,131

P.O. Box 1404  
Alexandria, Virginia 22313-1404  
(703) 836-6620

Date: November 27, 2001



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**INFORMATION DISCLOSURE STATEMENT  
TRANSMITTAL LETTER**

Assistant Commissioner for Patents  
Washington, D.C. 20231

Sir:

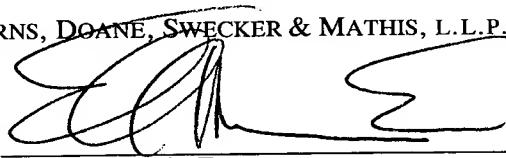
Enclosed is an Information Disclosure Statement and accompanying form PTO-1449 for the above-identified patent application.

- No additional fee for submission of an IDS is required.
- The fee of \$180.00 (126) as set forth in 37 C.F.R. § 1.17(p) is also enclosed.
- A certification under 37 C.F.R. § 1.97(e) is also enclosed.
- A certification under 37 C.F.R. § 1.97(e), and the fee of \$180.00 (126) as set forth in 37 C.F.R. § 1.17(p) are also enclosed.
- Charge \$\_\_\_\_\_ to Deposit Account No. 02-4800 for the fee due.
- A check in the amount of \$\_\_\_\_\_ is enclosed for the fee due.

The Commissioner is hereby authorized to charge any appropriate fees under 37 C.F.R. §§ 1.16, 1.17 and 1.21 that may be required by this paper, and to credit any overpayment, to Deposit Account No. 02-4800. This paper is submitted in duplicate.

Respectfully submitted,

BURNS, DOANE, SWECKER & MATHIS, L.L.P.

By:   
Ellen Marcie Emas  
Registration No. 32,131

P.O. Box 1404  
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